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Examiner Devices Pricto B.

Applicant(s)/Patent under Reexamination

MILOUSHEV ET AL.

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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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UPDATED TEXT BASED EAST SEARCH AS PER ATTACHED HISTORY (USPAT, PG_PUB, EPO, JPO, DERWENT & IBM_TDB)	3/1/2007	ьр		
INTERFERENCE TEXT BASED EAST SEARCH AS PER ATTACHED HISTORY (USPAT, PG_PUB, EPO, JPO, DERWENT & IBM_TDB)	3/1 <i>/</i> 2007	ВР		
INVENTOR & ASSIGNEE TEXT BASED EAST SEARCH AS PER ATTACHED HISTORY (USPAT, PG_PUB, EPO, JPO, DERWENT & IBM_TDB)	3/1/2007	ВР		
NPL TEXT BASED SEARCH AT GOOGLE-SCHOLAR	3/1/2007	BP.		
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